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REPETITIVE AVALANCHE AND dv/dt RATED HEXFET®TRANSISTORS THRU-HOLE (TO-204AA/AE)

IRF054 60V, N-CHANNEL

Product Summary

Part Number	BVDSS	RDS(on)	ID
IRF054	60V	0.022Ω	45A*

The HEXFET transistors also feature all of the well established advantages of MOSFETs such as voltage control, very fast switching, ease of paralleling and temperature stability of the electrical parameters.

They are well suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers and high energy pulse circuits.

Features:

- Repetitive Avalanche Ratings
- Dynamic dv/dt Rating
- Hermetically Sealed
- Simple Drive Requirements
- Ease of Paralleling

Absolute Maximum Ratings

	Parameter		Units
$I_D @ V_{GS} = 0V, T_C = 25^{\circ}C$	Continuous Drain Current	45*	
I _D @ V _{GS} =0V, T _C = 100°C Continuous Drain Current		3 1	A
IDM	Pulsed Drain Current ①	220	
P _D @ T _C = 25°C	Max. Power Dissipation	150	W
	Linear Derating Factor	1.2	W/°C
V _{GS}	Gate-to-Source Voltage	±20	V
EAS	Single Pulse Avalanche Energy ②	480	mJ
IAR	Avalanche Current ①	-	Α
EAR	Repetitive Avalanche Energy ①	-	mJ
dv/dt	Peak Diode Recovery dv/dt 3	4.5	V/ns
Тј	Operating Junction	-55 to 150	
TSTG	Storage Temperature Range		°C
	Lead Temperature	300 (0.063 in. (1.6mm) from case for 10s)	
	Weight	11.5(typical)	g

^{*} Current limited by pin diameter. For footnotes refer to the last page

NJ Semi-Conductors reserves the right to change test conditions, parameter limits and package dimensions without notice. Information furnished by NJ Semi-Conductors is believed to be both accurate and reliable at the time of going to press. However, NJ Semi-Conductors assumes no responsibility for any errors or omissions discovered in its use. NJ Semi-Conductors encourages customers to verify that datasheets are current before placing orders.

Quality Semi-Conductors

IRF054

Electrical Characteristics @ Tj = 25°C (Unless Otherwise Specified)

	Parameter	Min .	Тур	Max	Units	Test Conditions
BVDSS	Drain-to-Source Breakdown Voltage	60			V	$V_{GS} = 0V, I_{D} = 1.0 \text{mA}$
$\Delta BV_{DSS}/\Delta T_J$	Temperature Coefficient of Breakdown Voltage	_	0.68		V/°C	Reference to 25° C, $1_D = 1.0$ mA
RDS(on)	Static Drain-to-Source On-State	-	_	0.022	0	$V_{GS} = 10V, I_D = 31A$ (6)
	Resistance			0.025	Ω	V _{GS} = 10V, I _D =45A ③
V _{GS(th)}	Gate Threshold Voltage	2.0	_	4.0	V	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$
gfs	Forward Transconductance	20			S (75)	$V_{DS} > 15V$, $I_{DS} = 31A$ @
IDSS	Zero Gate Voltage Drain Current			25		V _{DS} =48V,V _{GS} =0V
				250	μА	V _{DS} = 48V
						$V_{GS} = 0V, T_J = 125^{\circ}C$
IGSS	Gate-to-Source Leakage Forward	_		100	- 1	V _{GS} = 20V
IGSS	Gate-to-Source Leakage Reverse		_	-100	nA	$V_{GS} = -20V$
Qg	Total Gate Charge	80		180		V _{GS} =10V, ID =45A
Qgs	Gate-to-Source Charge	20		45	nC	$V_{DS} = 30V$
Qgd	Gate-to-Drain ('Miller') Charge	34		105		
td(on)	Turn-On Delay Time	_		33		V _{DD} =30V, I _D =45A,
tr	Rise Time	_		180		$R_G = 2.35\Omega$
td(off)	Turn-Off Delay Time		_	100	ns	
tf	Fall Time		_	100		
LS + LD	Total Inductance		6.1	_	пH	Measured from drain lead (6mm/0.25in. from package) to source lead (6mm/0.25in. from package)
Ciss	Input Capacitance	_	4600			$V_{GS} = 0V$, $V_{DS} = 25V$
Coss	Output Capacitance		2000		pF	f = 1.0MHz
C _{rss}	Reverse Transfer Capacitance	_	340			

Source-Drain Diode Ratings and Characteristics

	Parameter		Min	Тур	Max	Units	Test Conditions
Is	Continuous Source Current (Body Diode)				45*	A	
ISM	Pulse Source Current (Body Diode) ①		_	_	220		
V _{SD}	Diode Forward Voltage			_	2.5	V	$T_j = 25^{\circ}C$, $I_S = 45A$, $V_{GS} = 0V$ ④
trr	Reverse Recovery Time		_	—	280	nS	$T_j = 25^{\circ}C$, $I_F = 45A$, $di/dt \le 100A/\mu s$
Qrr	Reverse Recovery Charge			_	2.2	μC	V _{DD} ≤ 50V ④
ton	Forward Turn-On Time	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by $L_S + L_D$.					

^{*}Current limited by pin diameter.

Thermal Resistance

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	Parameter	Min	Тур		Units	Test Conditions	
R _{th} JC	Junction to Case	_	_	0.83	°C/W		
RthIA	Junction to Ambient			30	C/ VV	Typical socket mount	